

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10773480	DIB ET AL.
Examiner	Art Unit	
Kim, Jennifer	1617	

SEARCHED

Class	Subclass	Date	Examiner
514	226.2	7/23/2007	jmk
Updated		5/22/2008	jmk
Updated		1/9/2009	jmk

SEARCH NOTES

Search Notes	Date	Examiner
STIC ; inventor serach; STN (registry, medicine)	7/23/2007	jmk
Updated	5/22/2008	jmk
Updated	1/9/2009	jmk

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
514	226.2	1/9/2009	jmk